


Search Notes 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/673,041		SOHIER ET AL.	
	Examiner		Art Unit	
	Tae H. Yoon		1714	

SEARCHED			
Class	Subclass	Date	Examiner
524	17	9-15-04	24
524	601		
424	426		
427	2.1		
ATD		5-3-06	44
424	480	8-16-06	42
ATD		11/31/07	2

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
424	426	2/5/02	2

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Inventor Search	9-6-05	24
EAST	8-14-06	42